

<b>Notice of References Cited</b>	Application/Control No. 09/224,211		Applicant(s)/Patent Under Reexamination WASSOM ET AL.	
	Examiner Ba Huynh		Art Unit 2179	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,184,886	02-2001	Bates et al.	715/760
*	B	US-6,557,015	04-2003	Bates et al.	715/501.1
*	C	US-6,832,350	12-2004	Bates et al.	715/501.1
*	D	US-6,628,314	09-2003	Hoyle, Martin David	715/854
*	E	US-5,917,491	06-1999	Bauersfeld, Kristin	715/810
*	F	US-2002/0107946	08-2002	ALBERS, MICHAEL C.	709/223
*	G	US-6,487,557	11-2002	Nagatomo, Shoichi	707/102
*	H	US-2002/0091697	07-2002	HUANG et al.	707/10
*	I	US-6,742,030	05-2004	MacPhail, Margaret Gardner	709/224
*	J	US-2004/0165007	08-2004	Shafron, Thomas J.	345/781
*	K	US-6,161,139	12-2000	Win et al.	709/225
*	L	US-2002/0059402	05-2002	BELANGER, CHARLES E.	709/220
*	M	US-6,741,967	05-2004	Wu et al.	705/10

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.